

RENESAS LSIs

# M5M5256DFP,VP-55LL,-70LL,-70LLI, -55XL,-70XL

262144-BIT (32768-WORD BY 8-BIT) CMOS STATIC RAM

## DESCRIPTION

The M5M5256DFP,VP is 262,144-bit CMOS static RAMs organized as 32,768-words by 8-bits which is fabricated using high-performance 3 poly silicon CMOS technology. The use of resistive load NMOS cells and CMOS periphery results in a high density and low power static RAM. Stand-by current is small enough for battery back-up application. It is ideal for the memory systems which require simple interface.

Especially the M5M5256DVP are packaged in a 28-pin thin small outline package.

## FEATURE

Type	Access time (max)	Operating Temperature	Power supply current	
			Active (max)	Stand-by (max)
M5M5256DFP,VP-55LL M5M5256DFP,VP-70LL	55ns 70ns	0~70°C	50mA (V <sub>CC</sub> =5.5V)	20µA (V <sub>CC</sub> =5.5V)
M5M5256DFP,VP-70LLI	70ns	-40~85°C		40µA (V <sub>CC</sub> =5.5V)
M5M5256DFP,VP-55XL M5M5256DFP,VP-70XL	55ns 70ns	0~70°C		5µA (V <sub>CC</sub> =5.5V) 0.05µA (V <sub>CC</sub> =3.0V, Typical)

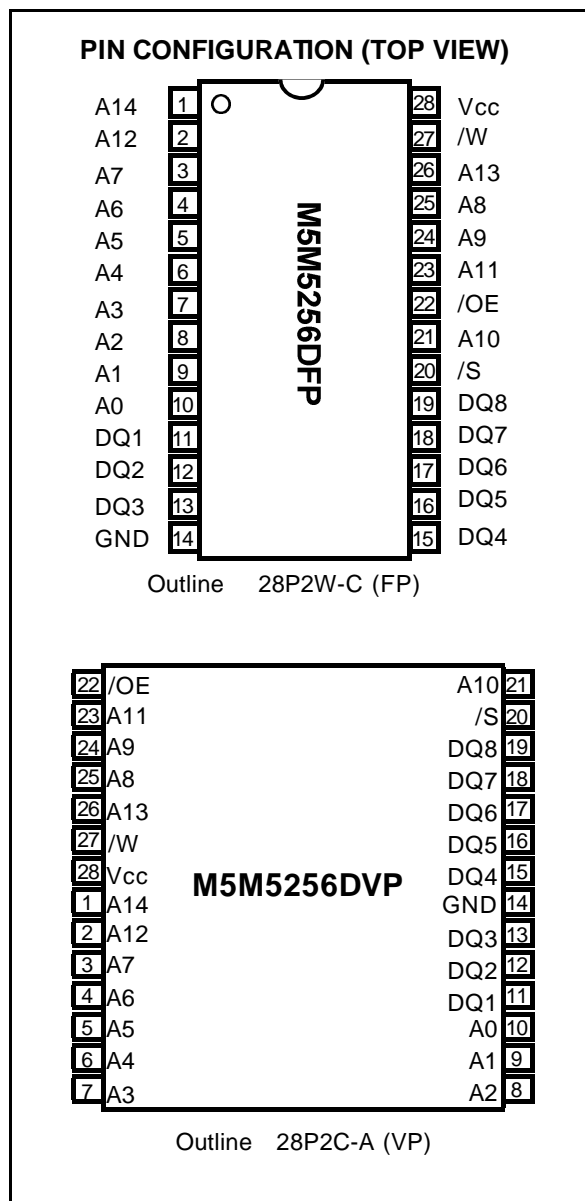
- Single +5V power supply
- No clocks, no refresh
- Data-Hold on +2.0V power supply
- Directly TTL compatible : all inputs and outputs
- Three-state outputs : OR-tie capability
- /OE prevents data contention in the I/O bus
- Common Data I/O
- Battery backup capability
- Low stand-by current ..... 0.05µA(typ.)

## PACKAGE

M5M5256DFP : 28 pin 450 mil SOP  
M5M5256DVP : 28pin 8 X 13.4 mm<sup>2</sup> TSOP

## APPLICATION

Small capacity memory units



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## FUNCTION

The operation mode of the M5M5256DFP,VP is determined by a combination of the device control inputs /S, /W and /OE. Each mode is summarized in the function table.

A write cycle is executed whenever the low level /W overlaps with the low level /S. The address must be set up before the write cycle and must be stable during the entire cycle. The data is latched into a cell on the trailing edge of /W, /S, whichever occurs first, requiring the set-up and hold time relative to these edge to be maintained. The output enable /OE directly controls the output stage. Setting the /OE at a high level, the output stage is in a high-impedance state, and the data bus contention problem in the write cycle is eliminated.

A read cycle is executed by setting /W at a high level and /OE at a low level while /S are in an active state.

When setting /S at a high level, the chip is in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips and memory expansion by /S. The power supply current is reduced as low as the stand-by current which is specified as Icc3 or Icc4, and the memory data can be held at +2V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

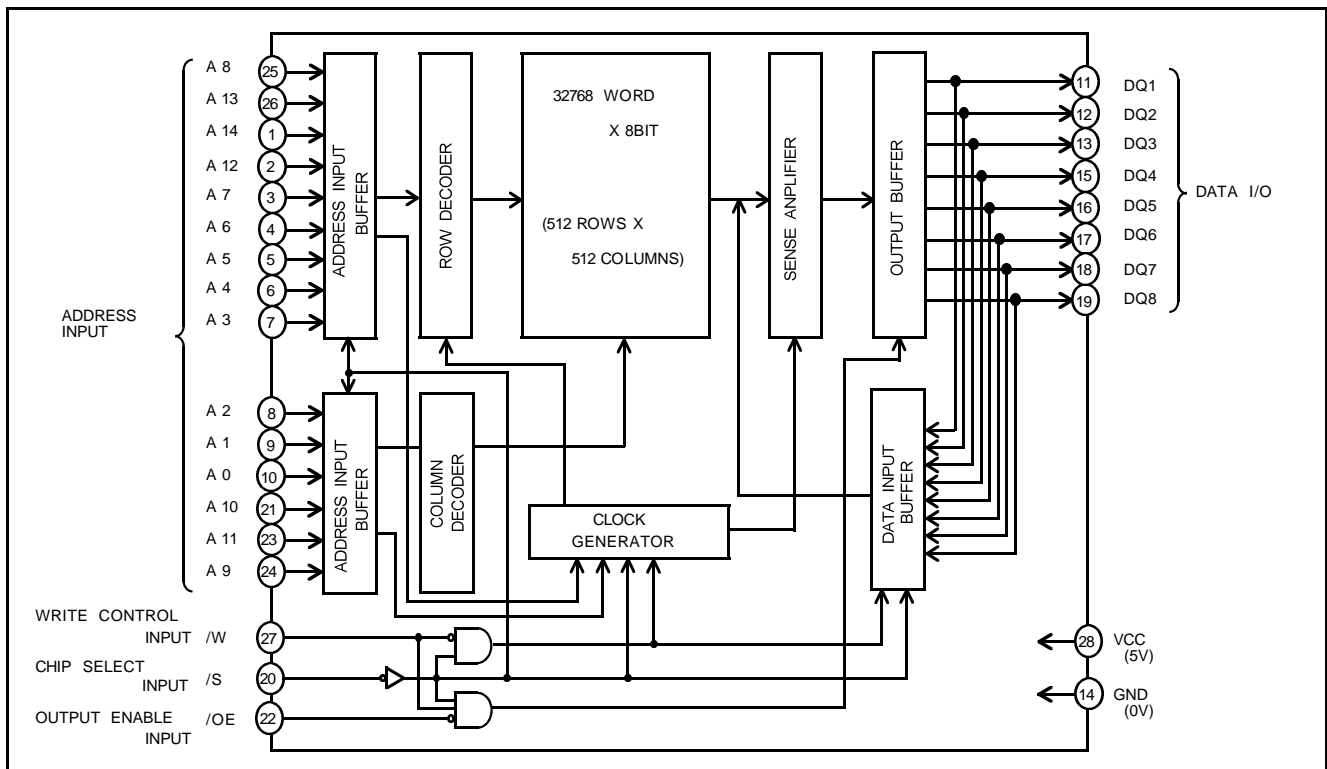
## FUNCTION TABLE

/S	/W	/OE	Mode	DQ	Icc
H	X	X	Non selection	High-impedance	Stand-by
L	L	X	Write	D <sub>IN</sub>	Active
L	H	L	Read	D <sub>OUT</sub>	Active
L	H	H		High-impedance	Active

Note • "H" and "L" in this table mean V<sub>IH</sub> and V<sub>IL</sub>, respectively.

• "X" in this table should be "H" or "L".

## BLOCK DIAGRAM



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## ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Unit
V <sub>cc</sub>	Supply voltage	With respect to GND	-0.3*~7.0	V
V <sub>i</sub>	Input voltage		-0.3*~V <sub>cc</sub> +0.3 (Max 7.0)	V
V <sub>o</sub>	Output voltage		0~V <sub>cc</sub>	V
P <sub>d</sub>	Power dissipation	T <sub>a</sub> =25°C	700	mW
T <sub>opr</sub>	Operating temperature	-LL, -XL	0~70	°C
		-LLI	-40~85	
T <sub>stg</sub>	Storage temperature		-65~150	°C

\* -3.0V in case of AC ( Pulse width < 30ns )

## DC ELECTRICAL CHARACTERISTICS ( V<sub>cc</sub>=5V±10%, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit	
			Min	Typ	Max		
V <sub>IH</sub>	High-level input voltage		2.2		V <sub>cc</sub> +0.3	V	
V <sub>IL</sub>	Low-level input voltage		-0.3*		0.8	V	
V <sub>OH1</sub>	High-level output voltage 1	I <sub>OH</sub> =-1mA	2.4			V	
V <sub>OH2</sub>	High-level output voltage 2	I <sub>OH</sub> =-0.1mA	V <sub>cc</sub> -0.5			V	
V <sub>OL</sub>	Low-level output voltage	I <sub>OL</sub> =2mA			0.4	V	
I <sub>i</sub>	Input current	V <sub>i</sub> =0~V <sub>cc</sub>			±1	µA	
I <sub>o</sub>	Output current in off-state	/S=V <sub>IH</sub> or /OE=V <sub>IH</sub> , V <sub>I/O</sub> =0~V <sub>cc</sub>			±1	µA	
I <sub>cc1</sub>	Active supply current (AC, MOS level)	/S≤0.2V, Other inputs<0.2V or >V <sub>cc</sub> -0.2V Output-open	55ns	30	45	mA	
			70ns	25	40		
			1MHz	2	4		
I <sub>cc2</sub>	Active supply current (AC, TTL level)	/S=V <sub>IL</sub> , other inputs=V <sub>IH</sub> or V <sub>IL</sub> Output-open	55ns	30	50	mA	
			70ns	25	45		
			1MHz	4	8		
I <sub>cc3</sub>	Stand-by current	/S>V <sub>cc</sub> -0.2V, other inputs=0~V <sub>cc</sub>	~25°C	-LL, -LLI		2	µA
				-XL	0.1	0.4	
			~40°C	-LL, -LLI		6	
				-XL		1.2	
			~70°C	-LL, -LLI		20	
-XL		5					
~85°C	-LLI		40				
I <sub>cc4</sub>	Stand-by current	/S=V <sub>IH</sub> , other inputs=0~V <sub>cc</sub>			3	mA	

\* -3.0V in case of AC ( Pulse width < 30ns )

## CAPACITANCE ( V<sub>cc</sub>=5V±10%, unless otherwise noted)

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
C <sub>i</sub>	Input capacitance	V <sub>i</sub> =GND, V <sub>i</sub> =25mVrms, f=1MHz			6	pF
C <sub>o</sub>	Output capacitance	V <sub>o</sub> =GND, V <sub>o</sub> =25mVrms, f=1MHz			8	pF

Note 0: Direction for current flowing into an IC is positive (no mark).

1: Typical value is one at T<sub>a</sub> = 25°C.

2: C<sub>i</sub>, C<sub>o</sub> are periodically sampled and are not 100% tested.

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## AC ELECTRICAL CHARACTERISTICS (V<sub>CC</sub>=5V±10%, unless otherwise noted)

### (1) READ CYCLE

Symbol	Parameter	Limits				Unit
		-55LL, 55XL		-70LL, -70LLI, -70 XL		
		Min	Max	Min	Max	
t <sub>CR</sub>	Read cycle time	55		70		ns
t <sub>a(A)</sub>	Address access time		55		70	ns
t <sub>a(S)</sub>	Chip select access time		55		70	ns
t <sub>a(OE)</sub>	Output enable access time		30		35	ns
t <sub>dis(S)</sub>	Output disable time after /S high		20		25	ns
t <sub>dis(OE)</sub>	Output disable time after /OE high		20		25	ns
t <sub>en(S)</sub>	Output enable time after /S low	5		5		ns
t <sub>en(OE)</sub>	Output enable time after /OE low	5		5		ns
t <sub>v(A)</sub>	Data valid time after address	10		10		ns

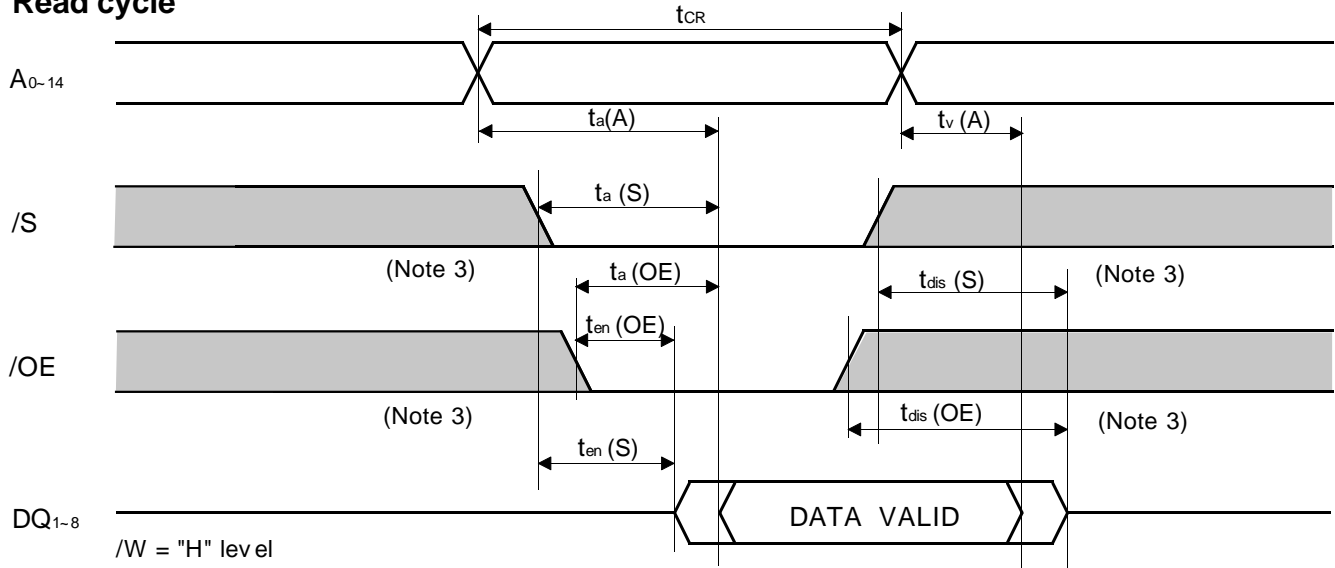
### (2) WRITE CYCLE

Symbol	Parameter	Limits				Unit
		-55LL, -55XL		-70LL, -70LLI, -70 XL		
		Min	Max	Min	Max	
t <sub>cw</sub>	Write cycle time	55		70		ns
t <sub>w(W)</sub>	Write pulse width	40		50		ns
t <sub>su(A)</sub>	Address setup time	0		0		ns
t <sub>su(A-WH)</sub>	Address setup time with respect to /W high	50		65		ns
t <sub>su(S)</sub>	Chip select setup time	50		65		ns
t <sub>su(D)</sub>	Data setup time	25		30		ns
t <sub>h(D)</sub>	Data hold time	0		0		ns
t <sub>rec(W)</sub>	Write recovery time	0		0		ns
t <sub>dis(W)</sub>	Output disable time from /W low		20		25	ns
t <sub>dis(OE)</sub>	Output disable time from /OE high		20		25	ns
t <sub>en(W)</sub>	Output enable time from /W high	5		5		ns
t <sub>en(OE)</sub>	Output enable time from /OE low	5		5		ns

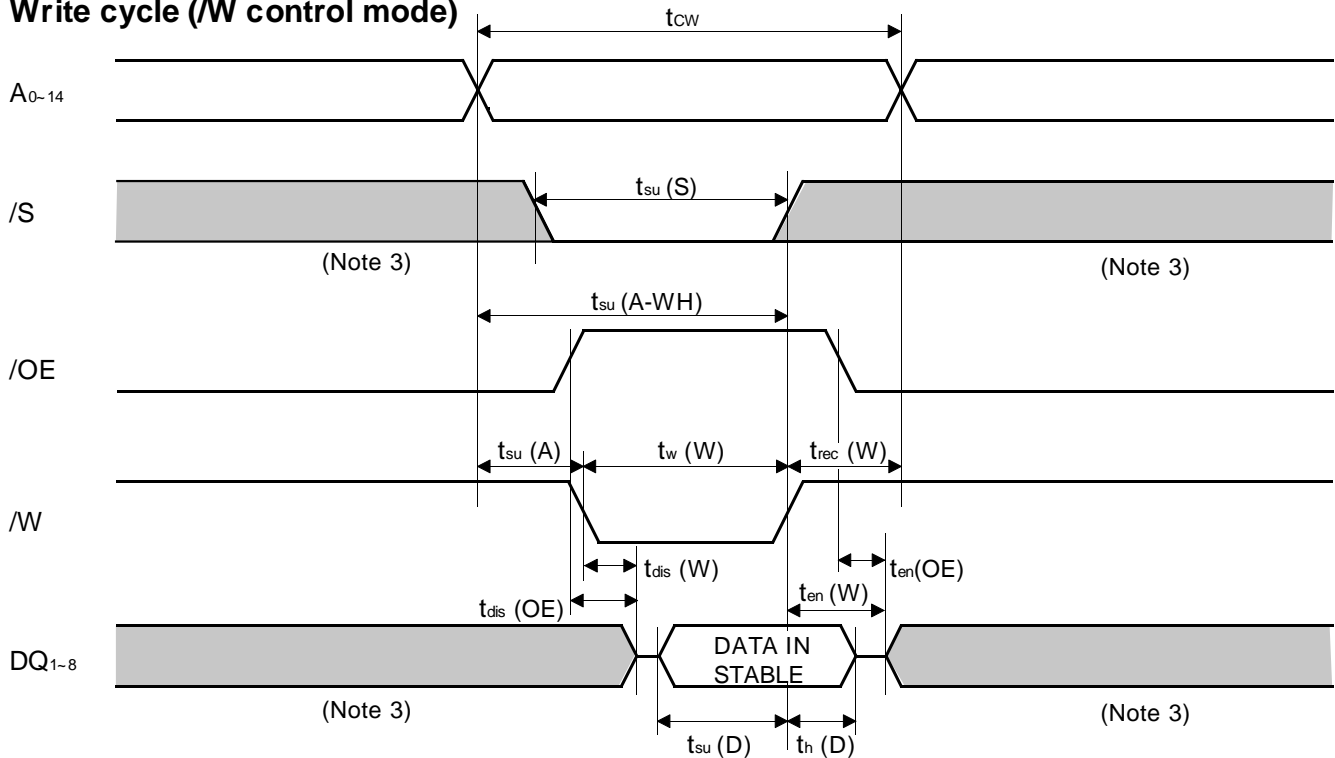
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**(3) TIMING DIAGRAMS**

**Read cycle**



**Write cycle (/W control mode)**





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**POWER DOWN CHARACTERISTICS**

**(1) ELECTRICAL CHARACTERISTICS** (  $V_{CC}=5V\pm 10\%$ , unless otherwise noted)

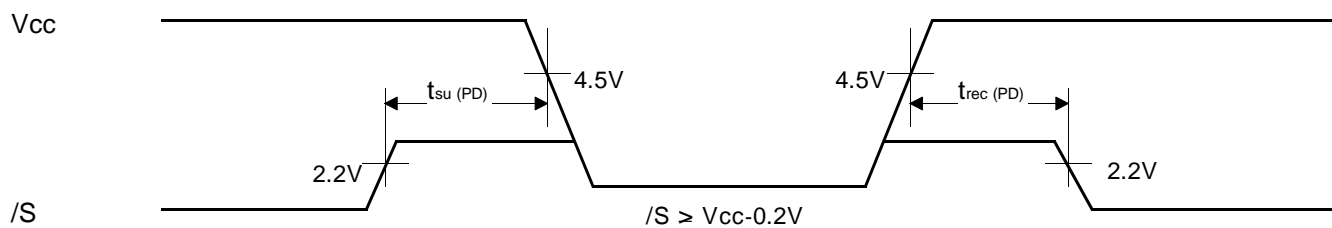
Symbol	Parameter	Test conditions	Limits			Unit	
			Min	Typ	Max		
$V_{CC(PD)}$	Power down supply voltage		2			V	
$V_I (/S)$	Chip select input /S	$2.2V \leq V_{CC(PD)}$	2.2			V	
		$2V \leq V_{CC(PD)} \leq 2.2V$		$V_{CC(PD)}$		V	
$I_{CC(PD)}$	Power down supply current	$V_{CC} = 3V, /S \geq V_{CC}-0.2V,$ Other inputs=0~ $V_{CC}$	~25°C	-LL,-LLI		1	$\mu A$
				-XL	0.05	0.2	
			~40°C	-LL,-LLI		3	
				-XL		0.6	
			~70°C	-LL,-LLI		10	
-XL		2					
~85°C	-LLI		20				

**(2) TIMING REQUIREMENTS** (  $V_{CC}=5V\pm 10\%$ , unless otherwise noted )

Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
$t_{su(PD)}$	Power down set up time		0			ns
$t_{rec(PD)}$	Power down recovery time		tCR			ns

**(3) POWER DOWN CHARACTERISTICS**

**/S control mode**



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## Renesas Technology Corp.

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